

Notice of References Cited	Application/Control No. 09/275,883	Applicant(s)/Patent Under Reexamination RENNER ET AL.	
	Examiner Richard Schnizer, Ph. D	Art Unit 1635	Page 1 of 2

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Shirako et al (J. Virol. 72(3):2310-2315, 3/1998)
*	V	Suopanki et al (J. Gen. Virol. (79:309-319, 1998)
*	W	Frolov et al al (J. Virol. 73(5):3854-3865, 1999)
*	X	Shirako et al (Virology 177: 54-64, 1990)

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	Examiner Richard Schnizer, Ph. D	Art Unit 1635	Page 2 of 2

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*	U	Hardy et al (Virology 177: 199-208, 1990)
*	V	Perri et al (J. Virol. 74(20): 9802-9807, 2000)
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